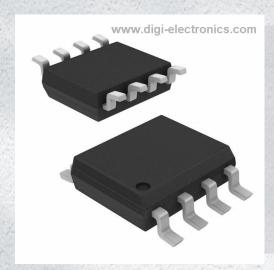


SI9424DY Datasheet



https://www.DiGi-Electronics.com

DiGi Electronics Part Number SI9424DY-DG

Manufacturer onsemi

Manufacturer Product Number SI9424DY

Description MOSFET P-CH 20V 8A 8SOIC

Detailed Description P-Channel 20 V 8A (Ta) 2.5W (Ta) Surface Mount 8-

SOIC



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RFQ Email: Info@DiGi-Electronics.com

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Purchase and inquiry

Manufacturer Product Number: Manufacturer: SI9424DY onsemi Product Status: Series: PowerTrench® Obsolete FET Type: Technology: P-Channel MOSFET (Metal Oxide) Drain to Source Voltage (Vdss): Current - Continuous Drain (Id) @ 25°C: 20 V 8A (Ta) Drive Voltage (Max Rds On, Min Rds On): Rds On (Max) @ Id, Vgs: 2.5V, 4.5V 24m0hm @ 8A, 4.5V Vgs(th) (Max) @ Id: Gate Charge (Qg) (Max) @ Vgs: 1.5V @ 250µA 33 nC @ 5 V Vgs (Max): Input Capacitance (Ciss) (Max) @ Vds: ±10V 2260 pF @ 10 V FET Feature: Power Dissipation (Max): 2.5W (Ta) Operating Temperature: Mounting Type: -55°C ~ 150°C (TJ) **Surface Mount** Supplier Device Package: Package / Case: 8-SOIC 8-SOIC (0.154", 3.90mm Width) Base Product Number: S1942

Environmental & Export classification

Moisture Sensitivity Level (MSL):	REACH Status:
1 (Unlimited)	REACH Unaffected
ECCN:	HTSUS:
EAR99	8541.29.0095



January 2001

Si9424DY

Single P-Channel 2.5V Specified PowerTrench MOSFET

General Description

This P-Channel 2.5V specified MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize on-state resistance and yet maintain superior switching performance.

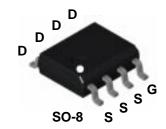
These devices are well suited for low voltage and battery powered applications where low in-line power loss and fast switching are required.

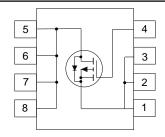
Applications

- DC/DC converter
- Load switch
- Battery Protection

Features

- -8.0 A, -20 V. $R_{DS(on)} = 0.024~\Omega~$ @ $V_{GS} =$ -4.5 V $R_{DS(on)} = 0.032~\Omega~$ @ $V_{GS} =$ -2.5 V.
- Low gate charge (23nC typical).
- Fast switching speed.
- $\bullet \;\;$ High performance trench technology for extremely low $R_{\mbox{\tiny DS(ION)}}.$
- High power and current handling capability.





Absolute Maximum Ratings T_A = 25°C unless otherwise noted

Absolute waxmam ratings 1,4-20 of the object of the way in the				
Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		-20	V
V _{GSS}	Gate-Source Voltage		± 10	V
I _D	Drain Current - Continuous	(Note 1a)	-8.0	Α
	- Pulsed		-50	
P _D	Power Dissipation for Single Operation	(Note 1a)	2.5	W
		(Note 1b)	1.2	
		(Note 1c)	1	
TJ, Tsta	Operating and Storage Junction Temperature Range		-55 to +150	°C

Thermal Characteristics

1110111101 0110100					
	$R_{\Theta^{JA}}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	50	°C/W
	$R_{ heta JC}$	Thermal Resistance, Junction-to-Case	(Note 1)	25	°C/W

Package Outlines and Ordering Information

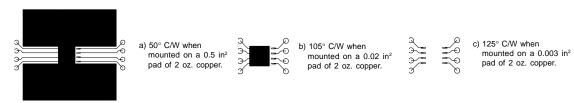
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Device Marking	Device	Reel Size	Tape Width	Quantity
9424	Si9424DY	13"	12mm	2500 units

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Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$	-20			V
<u>A</u> BVdss ΔTj	Breakdown Voltage Temperature Coefficient	I_D = -250 μ A, Referenced to 25°C		-24		mV/∘C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = -16 V, V _{GS} = 0 V			-1	μΑ
I_{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 10 V, V _{DS} = 0 V			100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -10 V, V _{DS} = 0 V			-100	nA
On Char	acteristics (Note 2)					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = -250 \mu\text{A}$	-0.4	-0.8	-1.5	V
<u>A</u> VGS(th) ΛΤ _J	Gate Threshold Voltage Temperature Coefficient	I_D = -250 μ A, Referenced to 25°C		5		mV/°C
$R_{DS(on)}$	Static Drain-Source On-Resistance	$V_{GS} = -4.5 \text{ V}, I_D = -8 \text{ A}$ $V_{GS} = -4.5 \text{ V}, I_D = -8 \text{ A}, T_J = 125 ^{\circ}\text{C}$ $V_{GS} = -2.5 \text{ V}, I_D = -7 \text{ A}$		0.019 0.026 0.027	0.024 0.039 0.032	Ω
I _{D(on)}	On-State Drain Current	$V_{GS} = -4.5 \text{ V}, V_{DS} = -5.0 \text{ V}$	-50			Α
g FS	Forward Transconductance	$V_{DS} = -5 \text{ V}, I_{D} = -8 \text{ A}$		28		S
Dynamic	Characteristics					
C _{iss}	Input Capacitance	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V},$		2260		pF
Coss	Output Capacitance	f = 1.0 MHz		500		pF
C _{rss}	Reverse Transfer Capacitance			205		pF
Switchin	g Characteristics (Note 2)					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = -10 \text{ V}, I_{D} = -1 \text{ A},$		8	16	ns
t _r	Turn-On Rise Time	V_{GS} = -4.5 V, R_{GEN} = 6 Ω		15	27	ns
$t_{d(off)}$	Turn-Off Delay Time			98	135	ns
t _f	Turn-Off Fall Time			35	55	ns
Q_g	Total Gate Charge	$V_{DS} = -10 \text{ V}, I_{D} = -8 \text{ A},$		23	33	nC
Q_{gs}	Gate-Source Charge	$V_{GS} = -5 V$,		5.5		nC
Q_{gd}	Gate-Drain Charge		_	4		nC
Drain-Sc	ource Diode Characteristics an	d Maximum Ratings				
Is	Maximum Continuous Drain-Source Die	_			-2.1	Α
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = -2.1 A (Note 2)		-0.75	-1.2	V

Notes

1: $R_{\theta,JA}$ is the sum of the junction-to-case and case-to-ambient resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta,JC}$ is guaranteed by design while $R_{\theta,JA}$ is determined by the user's board design.



Scale 1 : 1 on letter size paper

2: Pulse Test: Pulse Width $\leq 300~\mu s$, Duty Cycle $\leq 2.0\%$

Typical Characteristics

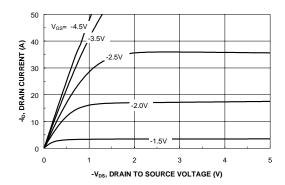


Figure 1. On-Region Characteristics.

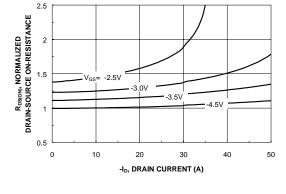


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

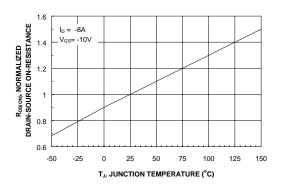


Figure 3. On-Resistance Variation with Temperature.

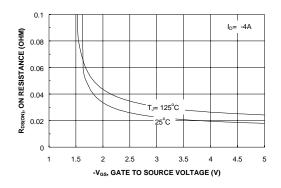


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

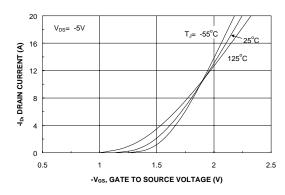


Figure 5. Transfer Characteristics.

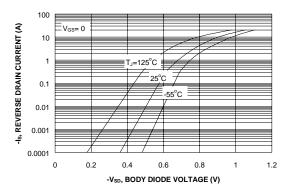
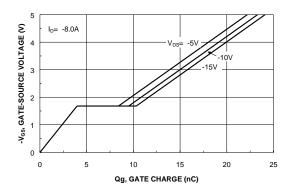


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics (continued)



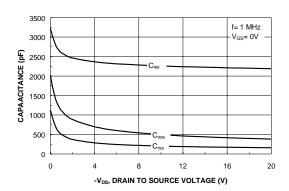
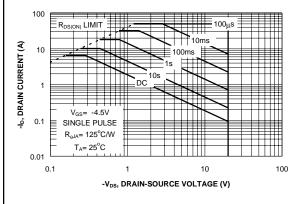


Figure 7. Gate Charge Characteristics.

Figure 8. Capacitance Characteristics.



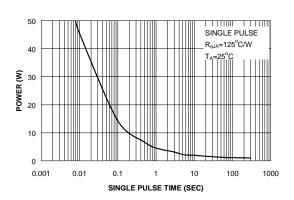


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

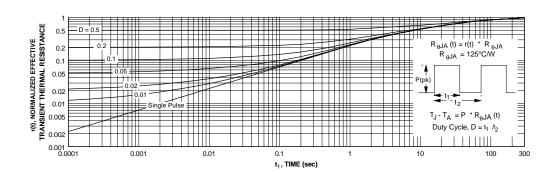


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient themal response will change depending on the circuit board design.

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